

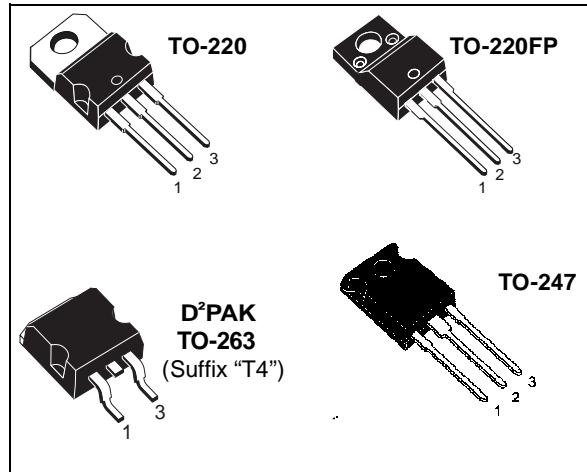


# STB80NF12 STW80NF12 STP80NF12 STP80NF12FP

N-CHANNEL 120V-0.013Ω-80A TO-220/TO-247/TO-220FP/D<sup>2</sup>PAK  
STripFET™ II POWER MOSFET

TYPE	V <sub>DSS</sub>	R <sub>D(on)</sub>	I <sub>D</sub>
STB80NF12	120 V	<0.018 Ω	80 A(*)
STP80NF12	120 V	<0.018 Ω	80 A(*)
STP80NF12FP	120 V	<0.018 Ω	80 A(*)
STW80NF12	120 V	<0.018 Ω	80 A(*)

- TYPICAL R<sub>D(on)</sub> = 0.013Ω
- EXCEPTIONAL dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- APPLICATION ORIENTED CHARACTERIZATION
- SURFACE-MOUNTING D<sup>2</sup>PAK (TO-263) POWER PACKAGE IN TUBE (NO SUFFIX) OR IN TAPE & REEL (SUFFIX "T4")



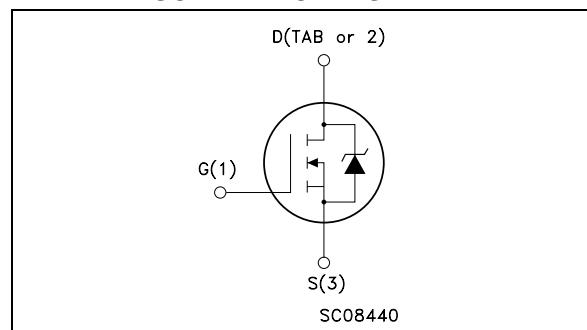
## DESCRIPTION

This MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced high-efficiency, high-frequency isolated DC-DC converters for Telecom and Computer applications. It is also intended for any applications with low gate drive requirements.

## APPLICATIONS

- HIGH-EFFICIENCY DC-DC CONVERTERS
- UPS AND MOTOR CONTROL

## INTERNAL SCHEMATIC DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value		Unit
		STB_P_W80NF12	STP80NF12FP	
V <sub>DS</sub>	Drain-source Voltage (V <sub>GS</sub> = 0)	120		V
V <sub>DGR</sub>	Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)	120		V
V <sub>GS</sub>	Gate-source Voltage	± 20		V
I <sub>D(*)</sub>	Drain Current (continuous) at T <sub>C</sub> = 25°C	80	80(#)	A
I <sub>D</sub>	Drain Current (continuous) at T <sub>C</sub> = 100°C	60	60(#)	A
I <sub>DM(•)</sub>	Drain Current (pulsed)	320	320(#)	A
P <sub>tot</sub>	Total Dissipation at T <sub>C</sub> = 25°C	300	45	W
	Derating Factor	2.0	0.3	W/°C
dv/dt (1)	Peak Diode Recovery voltage slope	10		V/ns
E <sub>AS</sub> (2)	Single Pulse Avalanche Energy	700		mJ
V <sub>ISO</sub>	Insulation Withstand Voltage (DC)	-----	2500	V
T <sub>stg</sub>	Storage Temperature	-55 to 175		°C
T <sub>j</sub>	Operating Junction Temperature	-55 to 175		°C

(\*) Pulse width limited by safe operating area.

(#) Refer to SOA for the max allowable current values on FP-type due to thermal resistance value.

(2) I<sub>SD</sub> ≤ 35A, di/dt ≤ 300A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>j</sub> ≤ T<sub>JMAX</sub>.

(1) Starting T<sub>j</sub> = 25 °C, I<sub>D</sub> = 40A, V<sub>DD</sub> = 45V

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### THERMAL DATA

			TO-247	D <sup>2</sup> PAK TO-220	TO-220FP	
R <sub>thj-case</sub>	Thermal Resistance Junction-case	Max	0.5	0.5	3.33	°C/W
R <sub>thj-amb</sub> $T_f$	Thermal Resistance Junction-ambient Maximum Lead Temperature For Soldering Purpose	Max 300	50 300	62.5 300	62.5 300	°C/W °C

### ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^\circ\text{C}$ unless otherwise specified)

#### OFF

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0	120			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max Rating V <sub>DS</sub> = Max Rating T <sub>C</sub> = 125°C			1 10	μA μA
I <sub>GSS</sub>	Gate-body Leakage Current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20V			±100	nA

#### ON (1)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> I <sub>D</sub> = 250 μA	2			V
R <sub>DS(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> = 10 V I <sub>D</sub> = 40 A		0.013	0.018	Ω

#### DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
g <sub>fs</sub> (*)	Forward Transconductance	V <sub>DS</sub> = 15 V I <sub>D</sub> = 40 A		80		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V <sub>DS</sub> = 25V f = 1 MHz V <sub>GS</sub> = 0		4300 600 230		pF pF pF

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### ELECTRICAL CHARACTERISTICS (continued)

#### SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$	Turn-on Delay Time Rise Time	$V_{DD} = 50 \text{ V}$ $I_D = 40 \text{ A}$ $R_G = 4.7 \Omega$ $V_{GS} = 10 \text{ V}$ (Resistive Load, Figure 3)		40 145		ns ns
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 80 \text{ V}$ $I_D = 80 \text{ A}$ $V_{GS} = 10 \text{ V}$		140 23 51	189	nC nC nC

#### SWITCHING OFF

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(off)}$ $t_f$	Turn-off Delay Time Fall Time	$V_{DD} = 50 \text{ V}$ $I_D = 40 \text{ A}$ $R_G = 4.7 \Omega$ , $V_{GS} = 10 \text{ V}$ (Resistive Load, Figure 3)		134 115		ns ns

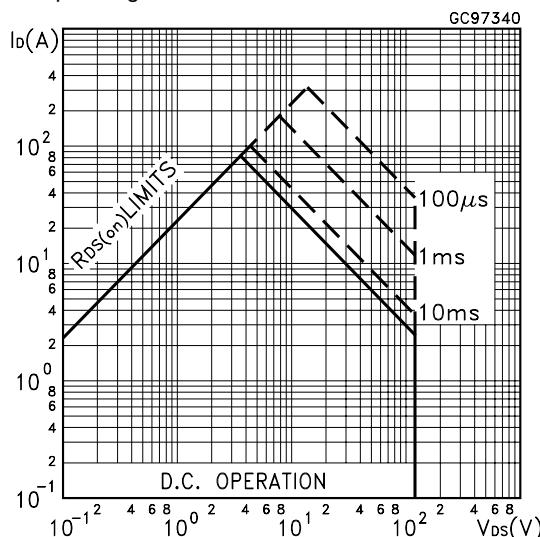
#### SOURCE DRAIN DIODE

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$I_{SD}$ $I_{SDM} (\bullet)$	Source-drain Current Source-drain Current (pulsed)				80 320	A A
$V_{SD} (*)$	Forward On Voltage	$I_{SD} = 80 \text{ A}$ $V_{GS} = 0$			1.3	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 80 \text{ A}$ $di/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 35 \text{ V}$ $T_j = 150^\circ\text{C}$ (see test circuit, Figure 5)		155 0.85 11		ns nC A

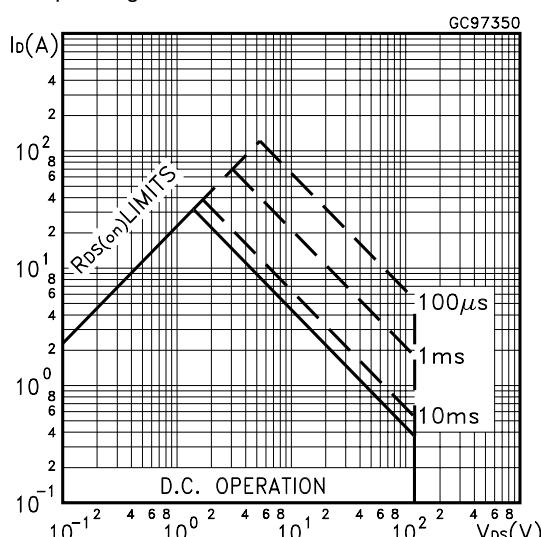
(\*)Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %.

(•)Pulse width limited by safe operating area.

Safe Operating Area

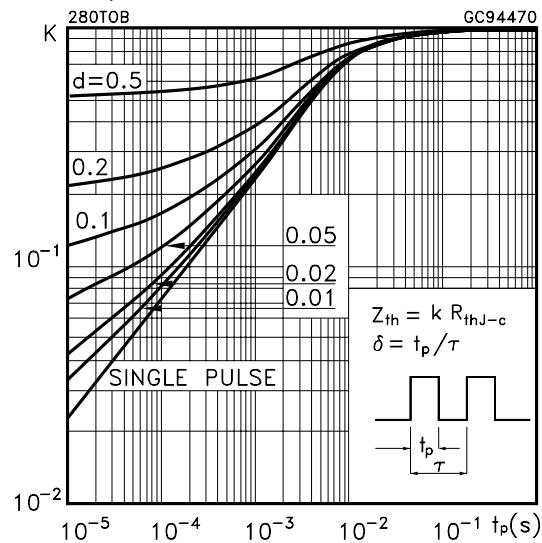


Safe Operating Area for TO-220FP

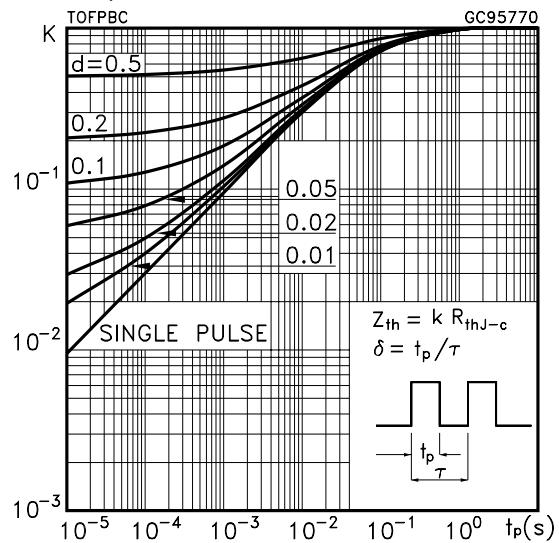


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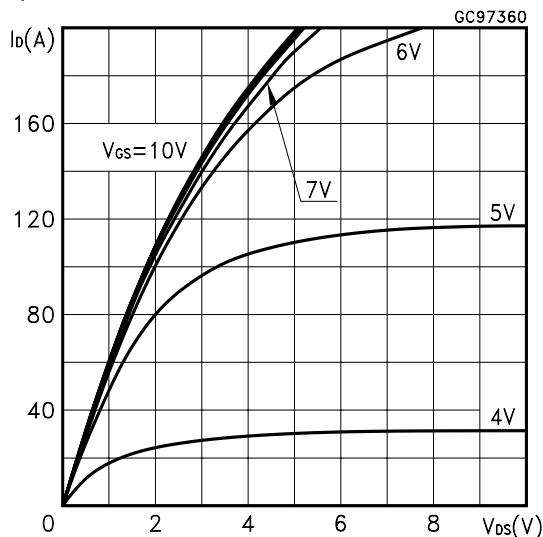
Thermal Impedance



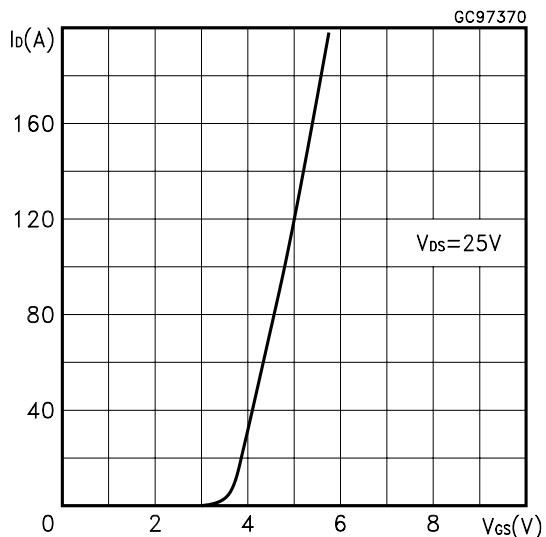
Thermal Impedance for TO-220FP



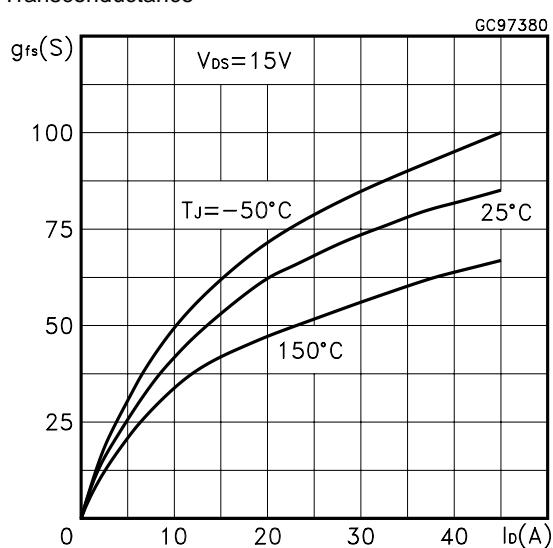
Output Characteristics



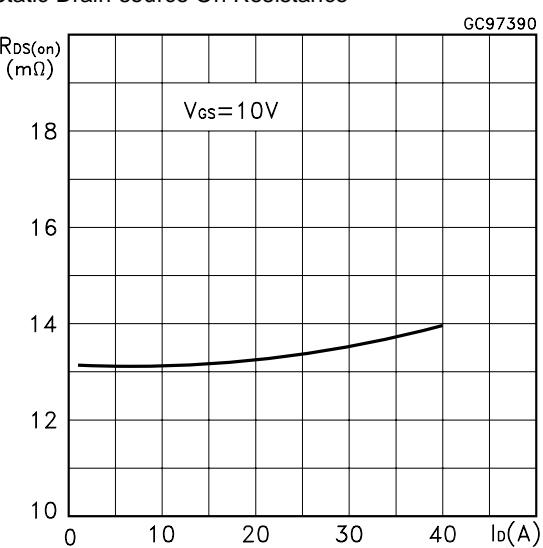
Transfer Characteristics



Transconductance

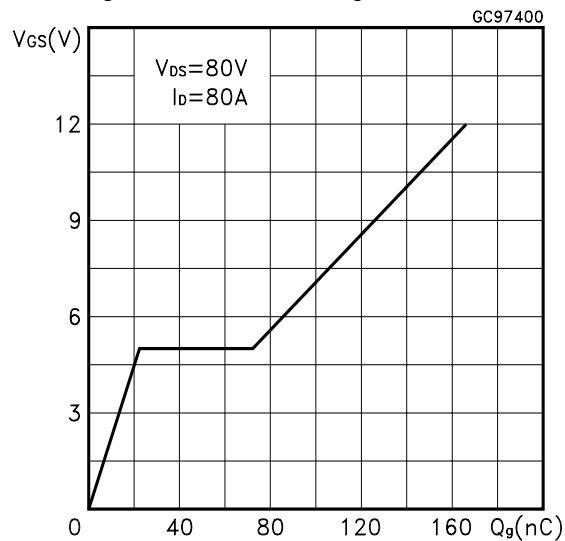


Static Drain-source On Resistance

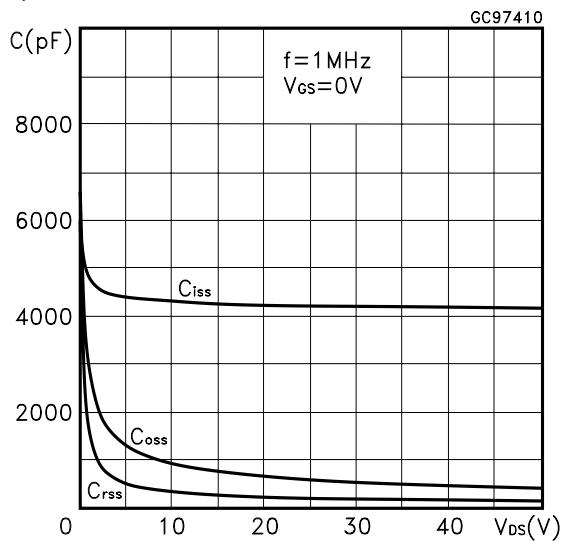


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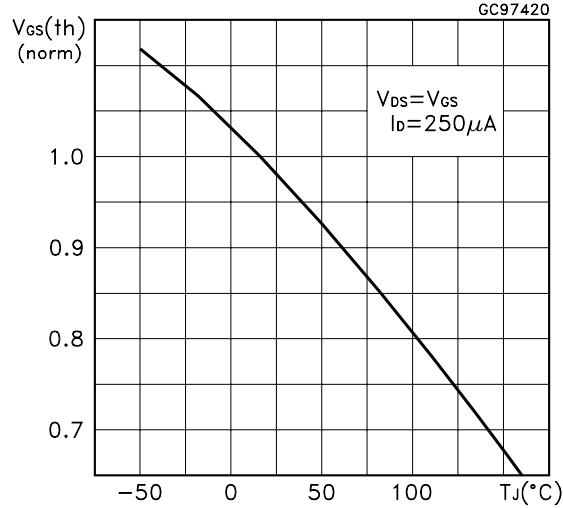
Gate Charge vs Gate-source Voltage



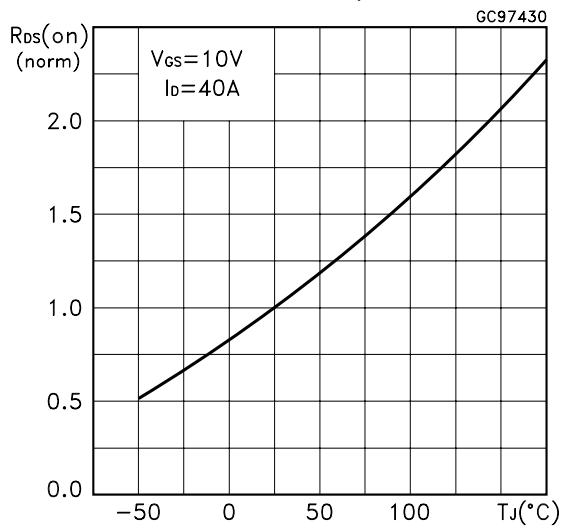
Capacitance Variations



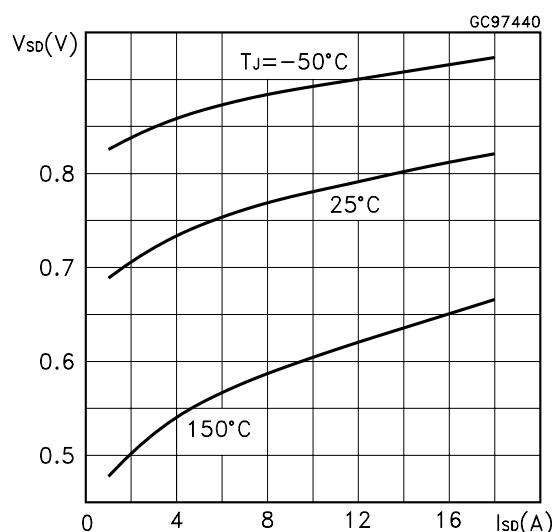
Normalized Gate Threshold Voltage vs Temperature



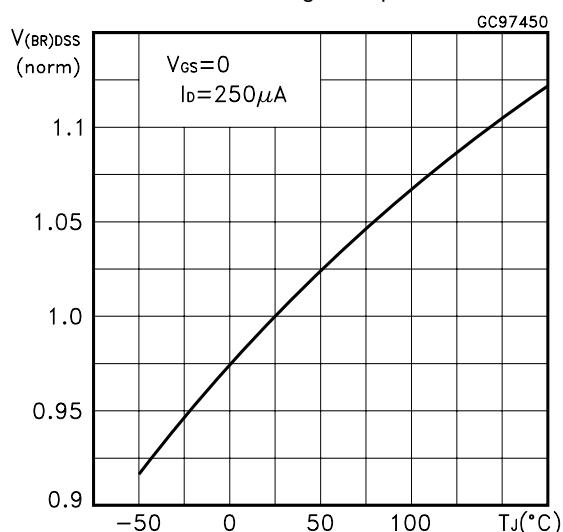
Normalized on Resistance vs Temperature



Source-drain Diode Forward Characteristics

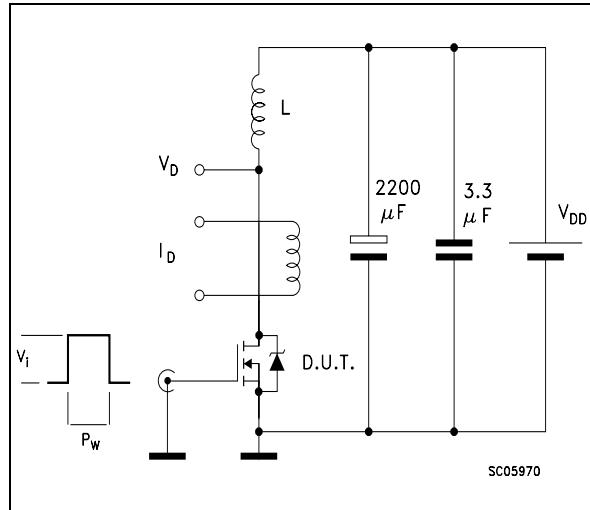


Normalized Breakdown Voltage Temperature

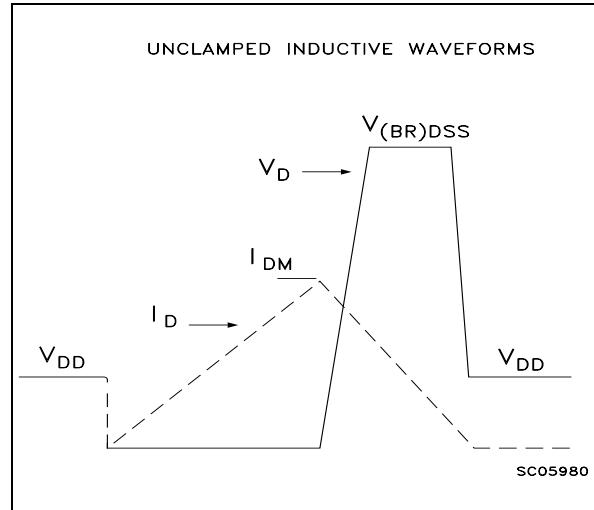


## STB80NF12 STW80NF12 STP80NF12 STP80NF12FP

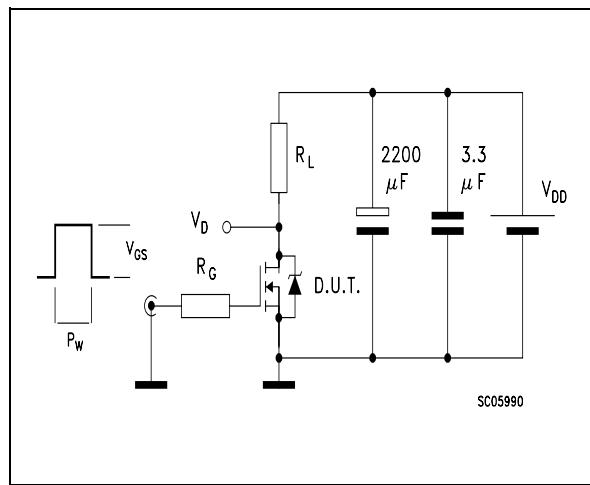
**Fig. 1: Unclamped Inductive Load Test Circuit**



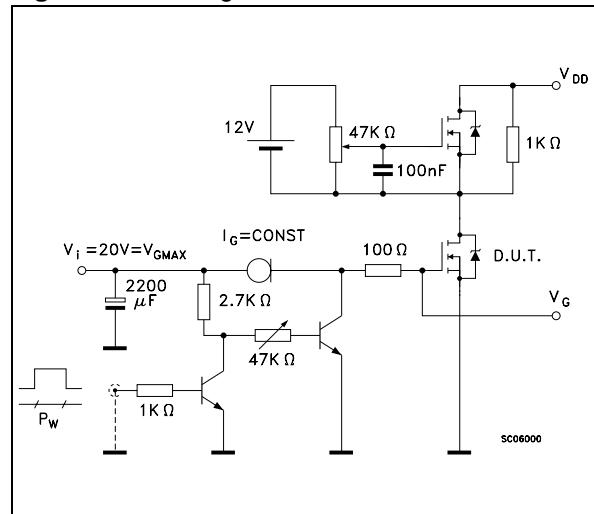
**Fig. 2: Unclamped Inductive Waveform**



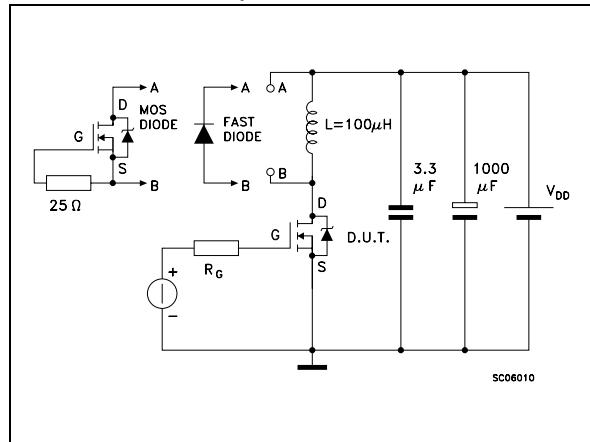
**Fig. 3: Switching Times Test Circuits For Resistive Load**



**Fig. 4: Gate Charge test Circuit**



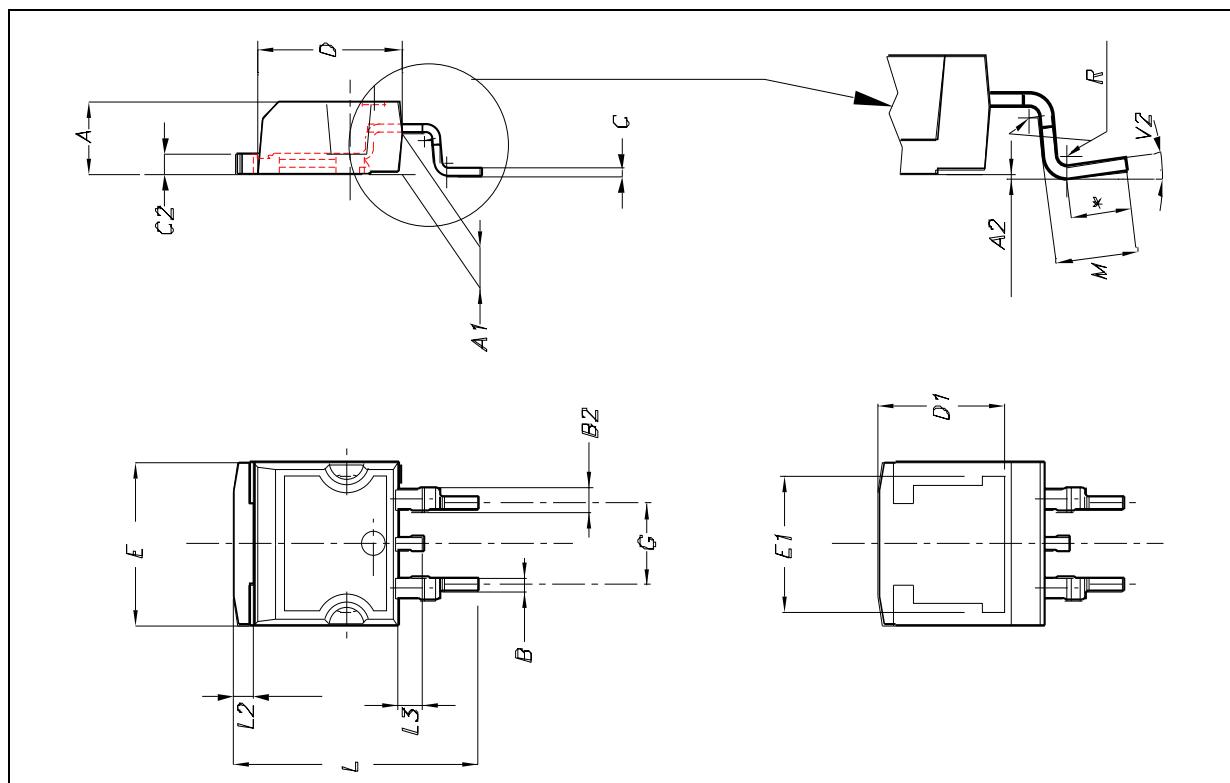
**Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times**



**STB80NF12 STW80NF12 STP80NF12 STP80NF12FP**

**D<sup>2</sup>PAK MECHANICAL DATA**

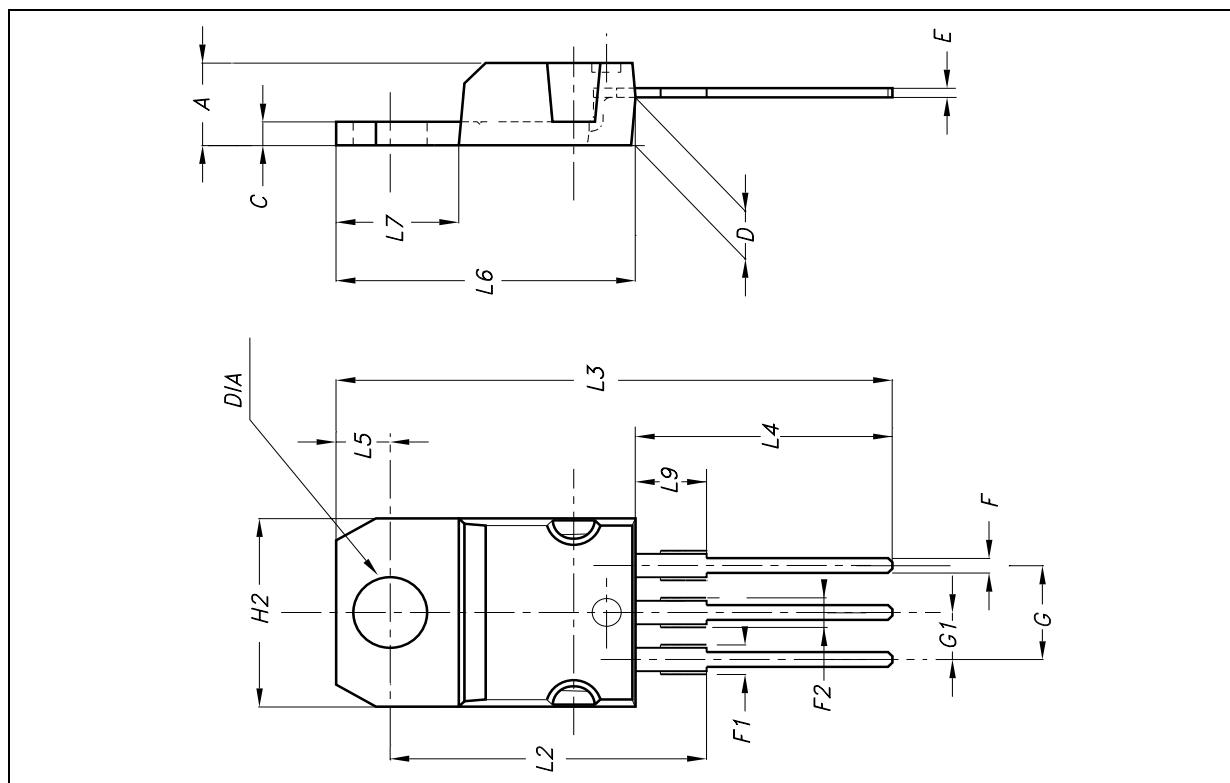
DIM.	mm.			inch.		
	MIN.	TYP.	MAX.	MIN.	TYP.	TYP.
<b>A</b>	4.4		4.6	0.173		0.181
<b>A1</b>	2.49		2.69	0.098		0.106
<b>A2</b>	0.03		0.23	0.001		0.009
<b>B</b>	0.7		0.93	0.028		0.037
<b>B2</b>	1.14		1.7	0.045		0.067
<b>C</b>	0.45		0.6	0.018		0.024
<b>C2</b>	1.21		1.36	0.048		0.054
<b>D</b>	8.95		9.35	0.352		0.368
<b>D1</b>		8			0.315	
<b>E</b>	10		10.4	0.394		0.409
<b>E1</b>	8.5				0.334	
<b>G</b>	4.88		5.28	0.192		0.208
<b>L</b>	15		15.85	0.591		0.624
<b>L2</b>	1.27		1.4	0.050		0.055
<b>L3</b>	1.4		1.75	0.055		0.069
<b>M</b>	2.4		3.2	0.094		0.126
<b>R</b>		0.4			0.016	
<b>V2</b>	0°		8°	0°		8°



**STB80NF12 STW80NF12 STP80NF12 STP80NF12FP**

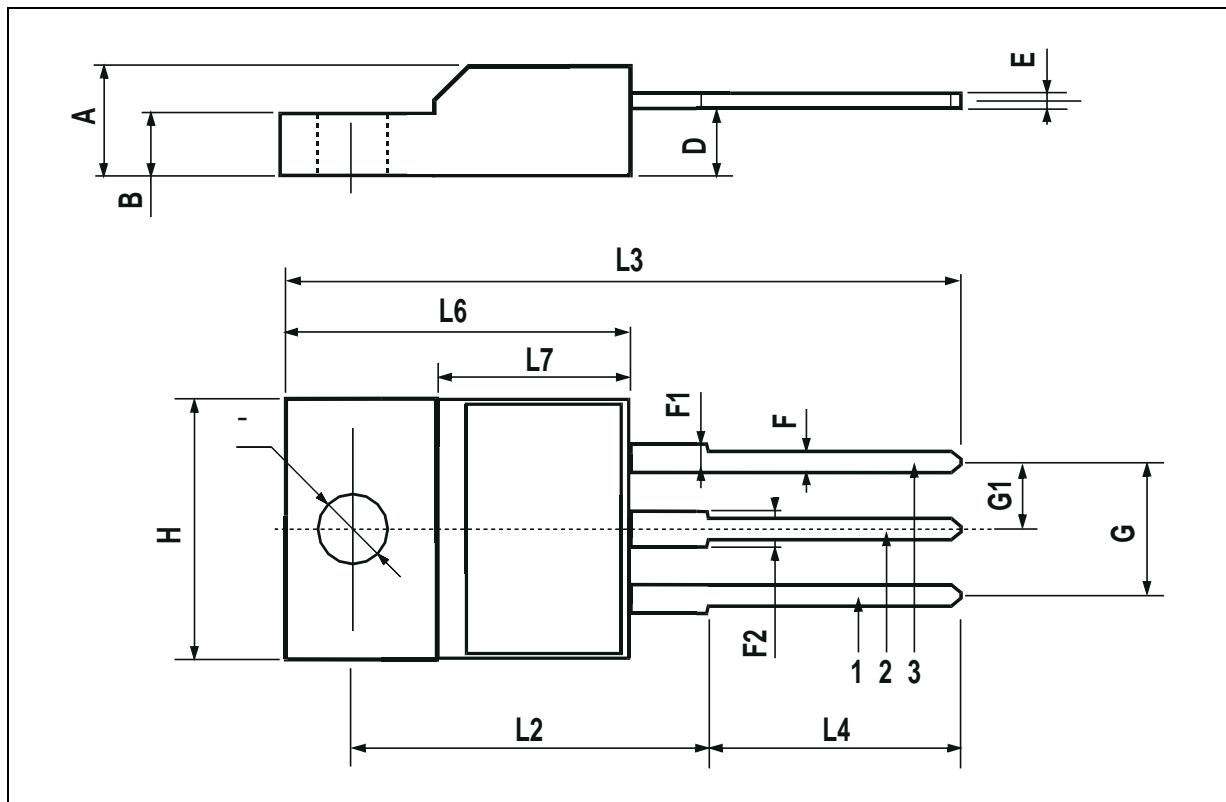
**TO-220 MECHANICAL DATA**

DIM.	mm.			inch.		
	MIN.	TYP.	MAX.	MIN.	TYP.	TYP.
<b>A</b>	4.4		4.6	0.173		0.181
<b>C</b>	1.23		1.32	0.048		0.051
<b>D</b>	2.40		2.72	0.094		0.107
<b>E</b>	0.49		0.70	0.019		0.027
<b>F</b>	0.61		0.88	0.024		0.034
<b>F1</b>	1.14		1.70	0.044		0.067
<b>F2</b>	1.14		1.70	0.044		0.067
<b>G</b>	4.95		5.15	0.194		0.203
<b>G1</b>	2.40		2.70	0.094		0.106
<b>H2</b>	10		10.40	0.393		0.409
<b>L2</b>		16.40			0.645	
<b>L3</b>		28.90			1.137	
<b>L4</b>	13		14	0.511		0.551
<b>L5</b>	2.65		2.95	0.104		0.116
<b>L6</b>	15.25		15.75	0.600		0.620
<b>L7</b>	6.20		6.60	0.244		0.260
<b>L9</b>	3.50		3.93	0.137		0.154
<b>DIA</b>	3.75		3.85	0.147		0.151



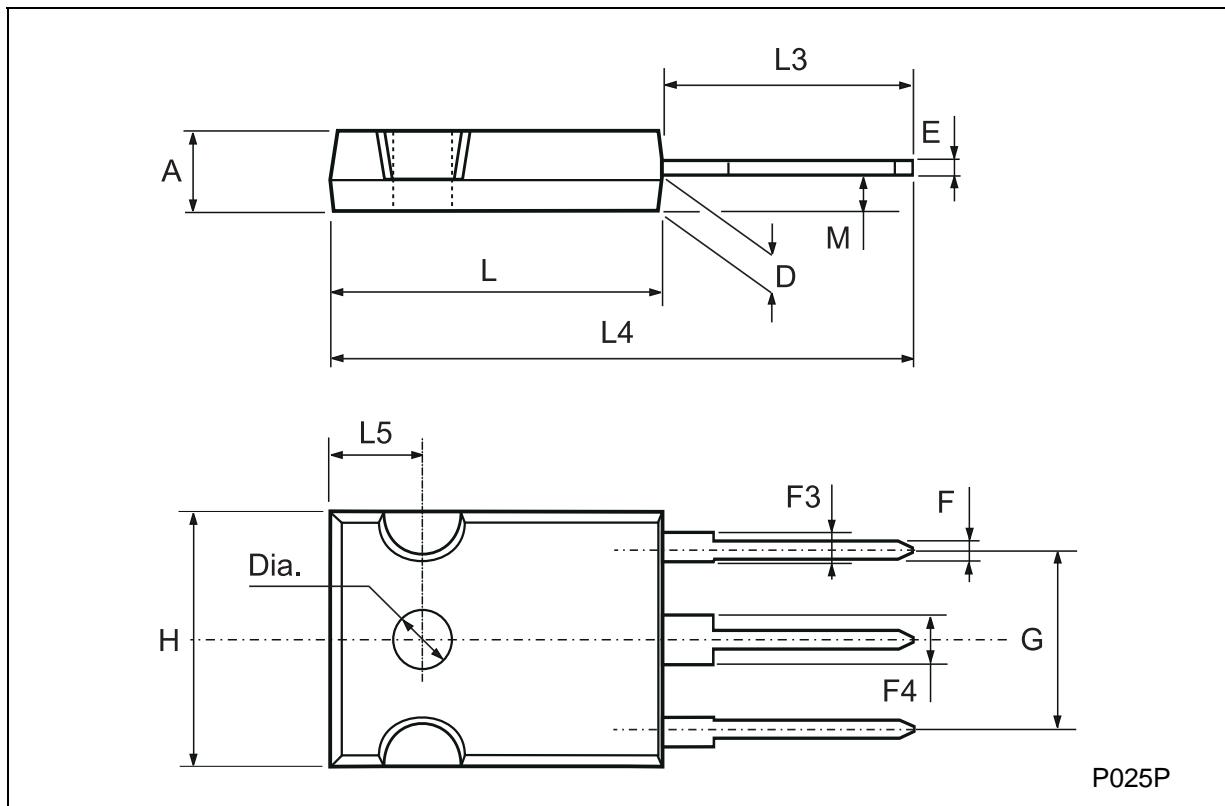
**TO-220FP MECHANICAL DATA**

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
B	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
H	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	0.385		0.417
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126

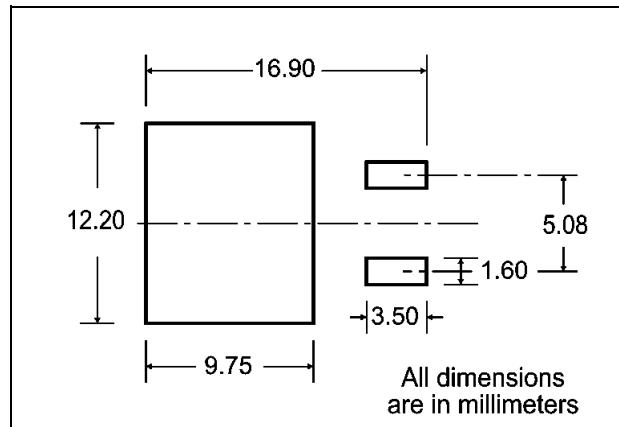


**TO-247 MECHANICAL DATA**

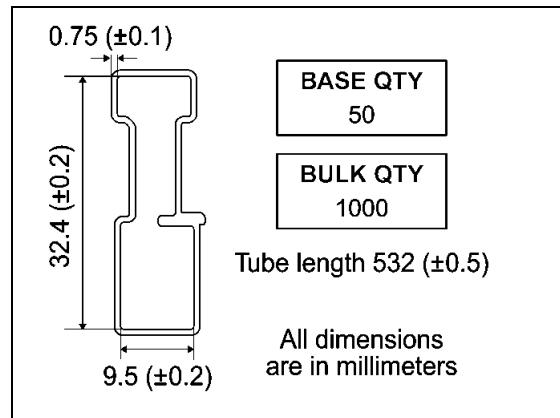
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.7		5.3	0.185		0.209
D	2.2		2.6	0.087		0.102
E	0.4		0.8	0.016		0.031
F	1		1.4	0.039		0.055
F3	2		2.4	0.079		0.094
F4	3		3.4	0.118		0.134
G		10.9			0.429	
H	15.3		15.9	0.602		0.626
L	19.7		20.3	0.776		0.779
L3	14.2		14.8	0.559		0.582
L4		34.6			1.362	
L5		5.5			0.217	
M	2		3	0.079		0.118



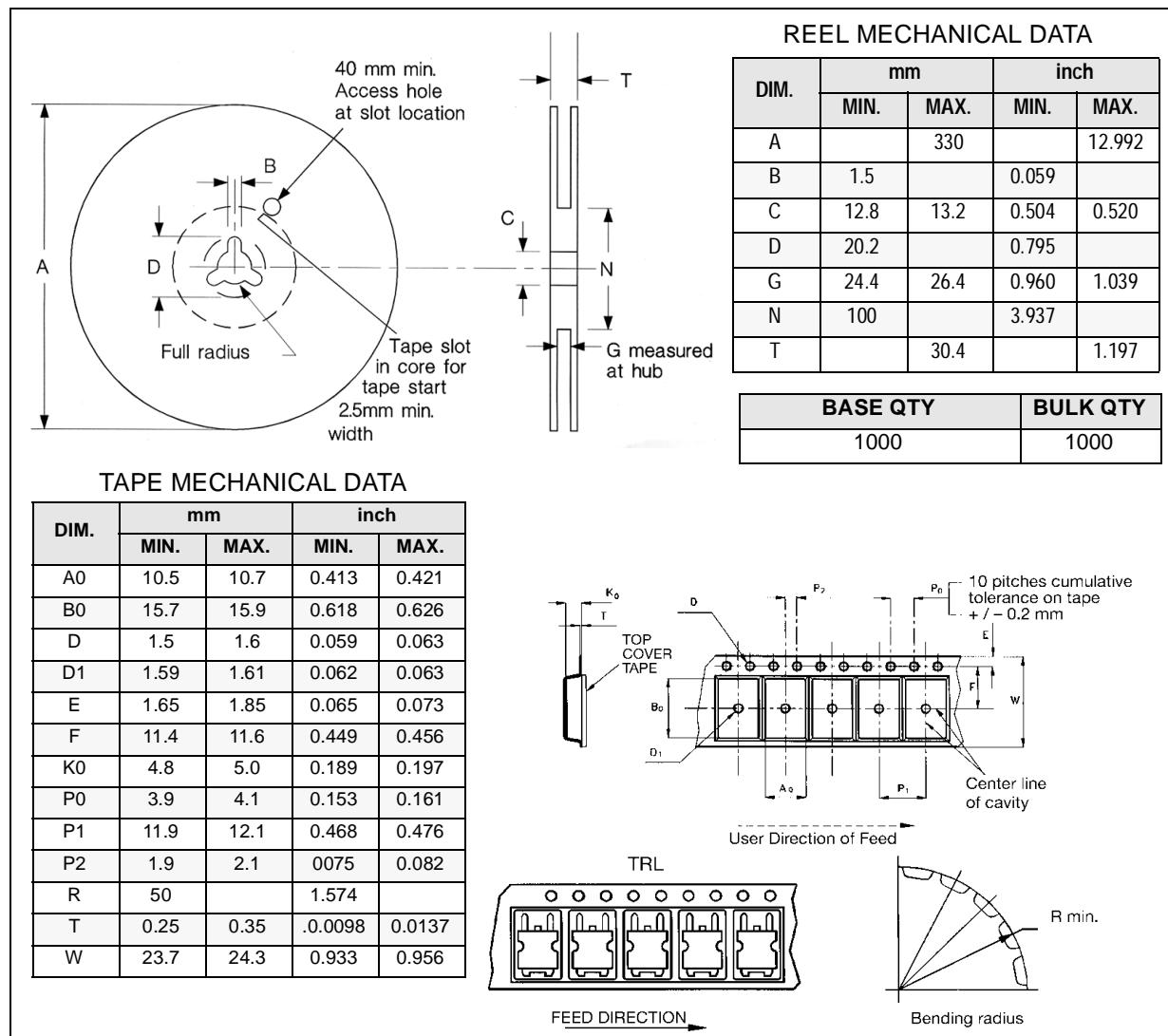
**D<sup>2</sup>PAK FOOTPRINT**



**TUBE SHIPMENT (no suffix)\***



**TAPE AND REEL SHIPMENT (suffix "T4")\***



\* on sales type

## **STB80NF12 STW80NF12 STP80NF12 STP80NF12FP**

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